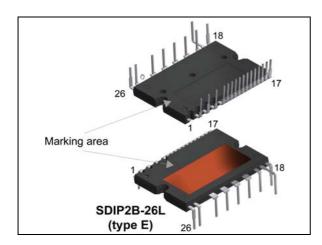


STGIB30CH60TS-E

Datasheet - preliminary data

SLLIMM[™] - 2nd series IPM, 3-phase inverter, 30 A, 600 V short-circuit rugged IGBTs



Features

- IPM 30 A, 600 V 3-phase IGBT inverter bridge including 2 control ICs for gate driving and freewheeling diodes
- 3.3 V, 5 V TTL/CMOS inputs with hysteresis
- Internal bootstrap diode
- Under-voltage lockout of gate drivers
- Smart shutdown function
- Short-circuit protection
- Shutdown input/fault output
- Separate open emitter outputs
- Temperature sensor integrated
- Comparator for fault protection
- Short circuit rugged TGFS IGBTs
- Very fast, soft recovery diodes
- 85 kΩ NTC UL 1434 CA 4 recognized
- Fully isolated package
- Isolation rating of 1500 Vrms/min
- SLLIMM UL 1557 recognition on going

Table 1. Device summary

Order code	Marking	Package	Packaging
STGIB30CH60TS-E	GIB30CH60TS-E	SDIP2B-26L	Tube

```
August 2014
```

DocID026593 Rev 2

This is preliminary information on a new product now in development or undergoing evaluation. Details are subject to change without notice.

Applications

- 3-phase inverters for motor drives
- Home appliances such as washing machines, refrigerators, air conditioners and sewing machine

Description

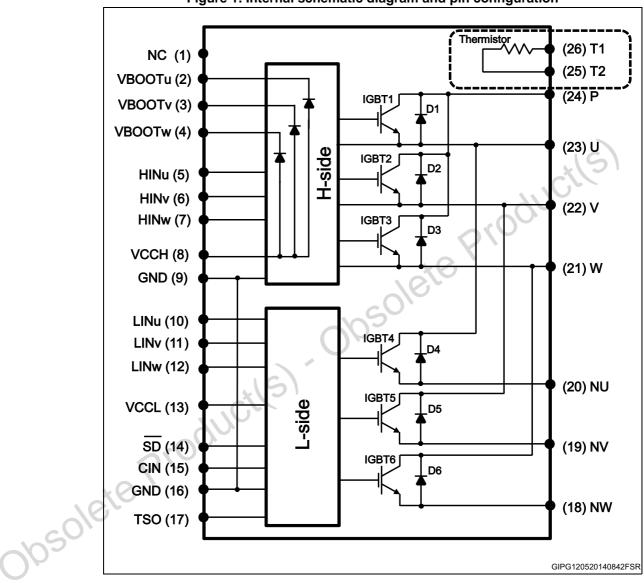
This second series of SLLIMM (small low-loss intelligent molded module) provides a compact, high performance AC motor drive in a simple, rugged design. It combines new ST proprietary control ICs (one LS and one HS driver) with the improved short-circuit rugged trench gate field-stop IGBT, making it ideal for 3-phase inverters systems such as home appliances and air conditioners. SLLIMM[™] is a trademark of STMicroelectronics.

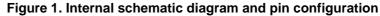
Contents

1	Internal schematic and pin description
2	Absolute maximum ratings5
3	Electrical characteristics7
4	Fault management 11
	4.1 TSO output
	4.2 Smart shutdown function
5	Typical application circuit
6	Recommendations
7	NTC thermistor
8	Package mechanical data 19
9	Revision history
0050	*



1 Internal schematic and pin description







	Pin	Symbol	Description
	1	NC	
	2	VBOOTu	Bootstrap voltage for U phase
	3	VBOOTv	Bootstrap voltage for V phase
	4	VBOOTw	Bootstrap voltage for W phase
	5	HINu	High-side logic input for U phase
	6	HIN∨	High-side logic input for V phase
	7	HINw	High-side logic input for W phase
	8	VCCH	High-side low voltage power supply
	9	GND	Ground
	10	LINu	Low-side logic input for U phase
	11	LINv	Low-side logic input for V phase
	12	LINw	Low-side logic input for W phase
	13	VCCL	Low-side low voltage power supply
	14	SD	Shutdown logic input (active low) / open-drain (comparator output)
	15	CIN	Comparator input
	16	GND	Ground
	17	TSO	Temperature sensor output
	18	NW	Negative DC input for W phase
	19	NV	Negative DC input for V phase
	20	NU	Negative DC input for U phase
cole	21	W	W phase output
050	22	V	V phase output
$\mathbf{O}^{\mathbf{r}}$	23	U	U phase output
	24	Р	Positive DC input
	25	T2	NTC thermistor terminal 2
	26	T1	NTC thermistor terminal 1
			1

Table 2. Pin description



Absolute maximum ratings 2

 $(T_i = 25^{\circ}C \text{ unless otherwise noted}).$

Symbol	Parameter	Value	Unit
V _{CC}	Supply voltage between P-N, -U,-V	450	V
/ _{CC(surge)}	Supply voltage surge between P-N, -U,-V	500	V
V _{CES}	Collector-emitter voltage each IGBT	600	V
Ι _C	Continuous collector current each IGBT	30	A
I _{CP}	Peak collector current each IGBT (less than 1ms)	60	A
P _{TOT}	Total dissipation at T_{C} =25°C each IGBT	797	W
t _{scw}	Short circuit withstand time, $V_{CE} = 300V$, $T_J = 125$ °C, $V_{CC} = V_{boot} = 15 V$, $V_{IN}^{(1)} = 0$ to 5 V	5	μs

Table 3. Inverter parts

Table 4. Control parts

	Symbol	Parameter	Min	Мах	Unit
	V _{CC}	Supply voltage between V_{CCH} -GND, V_{CCL} -GND	-0.3	20	V
	V _{BOOT}	Bootstrap voltage	-0.3	620	V
	V _{OUT}	Output voltage between U, V, W and GND	V _{BOOT} - 20	V _{BOOT} + 0.3	V
	V _{CIN}	Comparator input voltage	-0.3	15	V
10	V _{IN}	Logic input voltage applied between HINx, LINx and GND	-0.3	15	V
	V _{SD} /OD	Open drain voltage	-0.3	15	V
cO^{\prime}	I _{OD}	Open drain sink current	-	10	mA
-105	V _{TSO}	Temperature sensor output voltage	-0.3	7	V
JF					

Table 5. Total system

Symbol	Parameter	Value	Unit
V _{ISO}	Isolation withstand voltage applied between each pin and heat sink plate (AC voltage, $t = 60$ sec.)	1500	Vrms
TJ	Power chips operating junction temperature	-40 to 150	°C
Т _С	Module case operation temperature	-40 to 125	°C



	Table	6.	Thermal	data
--	-------	----	---------	------

Symbol			Unit
P	Thermal resistance junction-case single IGBT	-	
R _{th(j-c)}	Thermal resistance junction-case single diode	2.8	°C/W

Obsolete Product(s)- Obsolete Product(s)



3 **Electrical characteristics**

 $(T_i = 25^{\circ}C \text{ unless otherwise noted}).$

		Table 7. Inverter parts			-	
Symbol	Parameter	Test condition	Min	Тур	Мах	Unit
I _{CES}	Collector-cut off current	$V_{CE} = 550 \text{ V}, V_{CC} = V_{boot} = 15 \text{ V}$			-	μA
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{CC} = V_{Boot} = 15 \text{ V}, V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V},$ $I_{C} = 30 \text{ A},$		1.6	-	v
V _F	Diode forward voltage	V _{IN} ⁽¹⁾ = 0, I _C = 30 A		1.7	19	v
Inductive	e load switching time	and energy ⁽²⁾		77		1
t _{on}	Turn-on time		00			
t _{con}	Cross-over time on	$V_{DD} = 300 \text{ V}, V_{CC} = V_{boot} = 15 \text{ V},$ $V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V}, I_C = 30 \text{ A}$		-		
t _{off}	Turn-off time			-		ns
t _{coff}	Cross-over time off			-		
t _{rr}	Reverse recovery time			-		
E _{ON}	Turn-on switching loss			300		
E _{OFF}	Turn-off switching loss			120		μJ
	d between HINx, LINx and t _{off} include the propagatior Titself under the internally	GND for $x = U$, V, W a delay time of the internal drive. $t_{C(ON)}$ and t_{C} given gate driving condition.	_(OFF) are	e the swi	itching ti	me

Table	7.	Inverter	parts
-------	----	----------	-------



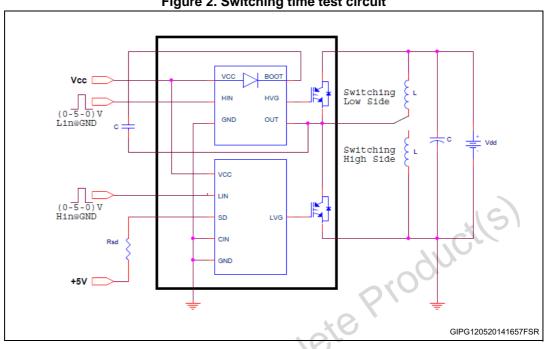
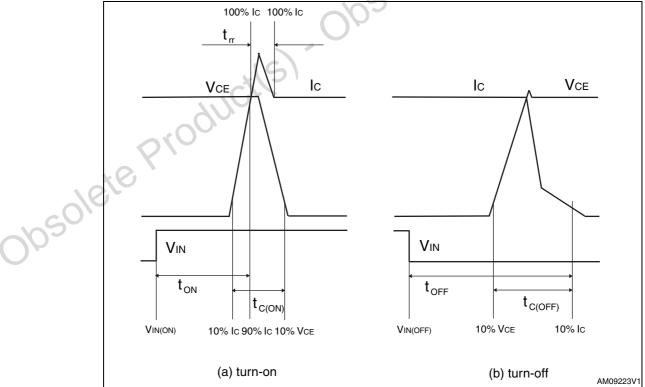


Figure 2. Switching time test circuit

Figure 3. Switching time definition





	Symbol	Parameter	Test condition	Min	Тур	Мах	Unit
	V _{CC_hys}	V _{CC} UV hysteresis		1.1	1.4	1.7	V
	V _{il}	Low logic level voltage				0.8	V
	V _{ih}	High logic level voltage		2			V
	I _{INh}	IN logic "1" input bias current	IN _x =15∨		150		μA
	I _{INI}	IN logic "0" input bias current	IN _x =0V			1	μA
	High side					10	5
	V _{CCH_th(on)}	V _{CCH} UV turn-on threshold		11	11.5	12	V
	V _{CCH_th(off)}	V _{CCH} UV turn-off threshold		9.6	10.1	10.6	V
	V _{BS_hys}	V _{BS} UV hysteresis	C	0.7	1	1.3	V
	V _{BS_th(on)}	V _{BS} UV turn-on threshold	× 9.	10.1	11	11.9	V
	V _{BS_th(off)}	V _{BS} UV turn-off threshold	161	9.1	10	10.9	V
	I _{QBSU}	Under voltage V _{BS} quiescent current	V _{BS} = 9 V, HINx ⁽¹⁾ = 5V;		45	-	μA
	I _{QBS}	V _{BS} quiescent current	$V_{CC} = 15 V,$ HINx ⁽¹⁾ = 5V		80	-	μA
	I _{qccu}	Under voltage quiescent supply current	$V_{CC} = 9 V$, HINx ⁽¹⁾ = 0		270	-	μA
	I _{qcc}	Quiescent current	$V_{CC} = 15 \text{ V}, \text{ HINx}^{(1)} = 0$		520	-	μA
	R _{DS(on)}	BS driver ON resistance			140		Ω
	Low side						
	V _{CCL_th(on)}	V _{CCL} UV turn-on threshold		11	11.5	12	V
N	V _{CCL_th(off)}	V _{CCL} UV turn-off threshold		9.6	10.1	10.6	V
50	I _{qccu}	Under voltage quiescent supply current	$V_{CC} = 10 \text{ V}, \overline{\text{SD}} \text{ pulled to}$ 5V through $R_{SD} = 10k\Omega$, CIN = LINx ¹⁾ = 0;		640	-	μA
	I _{qcc}	Quiescent current	$V_{CC} = 15 \text{ V}, \overline{\text{SD}} = 5\text{V},$ CIN = LINx ¹⁾ = 0;		740	-	μA
	V _{SSD}	Smart SD unlatch threshold			0.6		V
	I _{SDh}	SD logic "1" input bias current	<u>SD</u> =15V		150		μA
	I _{SDI}	SD logic "0" input bias current	SD =0∨			1	μΑ

Table 8. Control / protection parts

1. Applied between HINx, LINx and GND for x = U, V, W



Symbol	Parameter	Test condition	Min	Тур	Max	Unit
I _{ib}	Input bias current	V _{CIN} =1V	-	0	-	μΑ
V _{ref}	Internal reference voltage		-	500	-	mV
V _{OD}	Open drain low level output voltage	I _{od} =-5mA	-		500	mV
t _{d_comp}	Comparator delay	\overline{SD} pulled to 5V through R _{SD} =10k Ω ; measured applying a voltage step 0V-3.3V to Pin CIN 50% CIN to 90% \overline{SD}	-	30	je je	ns
SR	Slew rate	\overline{SD} pulled to 5V through R _{SD} =10kΩ; C _L =1nF through \overline{SD} and ground; 90% \overline{SD} to 10% \overline{SD}	<u>_0</u>	30		V/µs

Table 9. Sense comparator (V_{CC} = 15 V, PGND=AGND=GND, unless otherwise is specified)

Note:

. in U Ob Obsolete Product(S) Comparator stay enabled even if V_{CC} is in UVLO condition but higher than 4 V.



4 Fault management

The device integrates an open-drain output connected to SD Pin. As soon as a fault occurs the open-drain is activated and LVGx outputs are forced low. Two types of fault can be pointed out:

- Overcurrent (OC) sensed by the internal comparator (see more detail in Section 4.2: Smart shutdown function);
- Undervoltage on supply voltage (V_{CC});

Each fault enables the SD open drain for a different time; refer to the following *Table 10: Fault timing*.

Table 10. Fault timing				
Symbol	Parameter	Parameter Event time		
OC	Over-current event	≤ 20 µs	20 µs	
		≥ 20µs	OC time	
UVLO	Under-voltage lock out event	≤ 50 µs	50µs	
		≥ 50µs until the VCC_LS exceed the VCC_LS UV turn ON threshold	UVLO time	

Actually the device remains in a fault condition (\overline{SD} at low logic level and LVGx outputs disabled) for a time also depending on RC network connected to \overline{SD} pin. The network generate a time contribute that add up to the internal value.

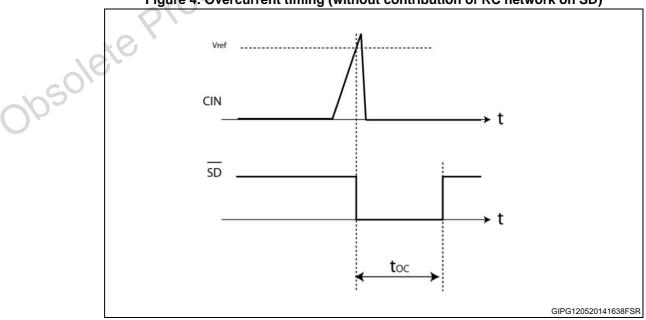
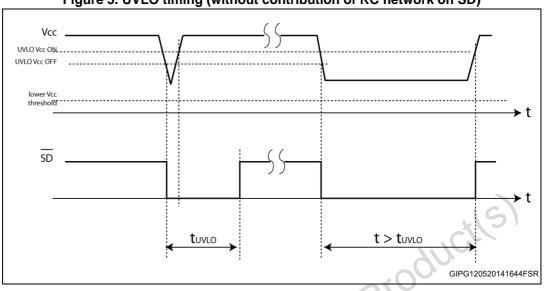


Figure 4. Overcurrent timing (without contribution of RC network on SD)







4.1 TSO output

The device integrates temperature sensor. A voltage proportional to die temperature is available on TSO pin. When this function is not used the Pin can be left floating.

4.2 Smart shutdown function

The device integrates a comparator committed to the fault sensing function. The comparator input can be connected to an external shunt resistor in order to implement a simple overcurrent detection function.

The output signal of the comparator is fed to an integrated MOSFET with the open drain output available on SD input. When the comparator triggers, the device is set in shutdown state and its outputs are all set to low level.



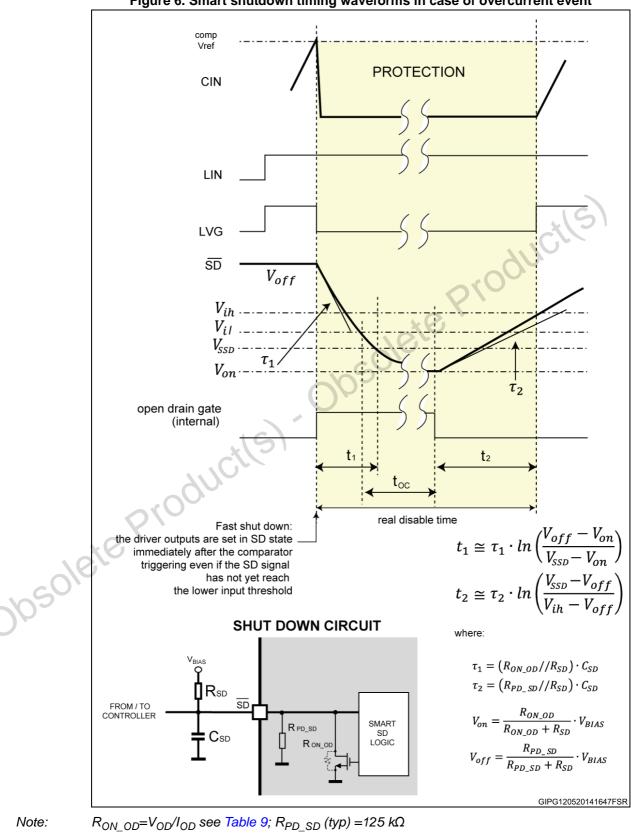


Figure 6. Smart shutdown timing waveforms in case of overcurrent event



In common over-current protection architectures the comparator output is usually connected to the SD input and an RC network is connected to this SD line in order to provide a monostable circuit, which implements a protection time that follows the fault condition.

Differently from the common fault detection systems, the device Smart shutdown architecture allows to immediately turn-off the outputs gate driver in case of fault, by minimizing the propagation delay between the fault detection event and the actual outputs switch-off. In fact the time delay between the fault and the outputs turn off is no more dependent on the RC value of the external network connected to the pin.

In the smart shutdown circuitry, the fault signal has a preferential path which directly switches off the outputs after the comparator triggering.

At the same time the internal logic turns on the open drain output and holds it on until the \overline{SD} voltage goes below the V_{SSD} threshold and t_{oc} time is elapsed.

The driver outputs restart following the input pins as soon as the voltage at the SD pin reaches the higher threshold of the SD logic input.

The Smart shutdown system provides the possibility to increase the time constant of the external RC network (that is the disable time after the fault event) up to very large values without increasing the delay time of the protection.



5 Typical application circuit

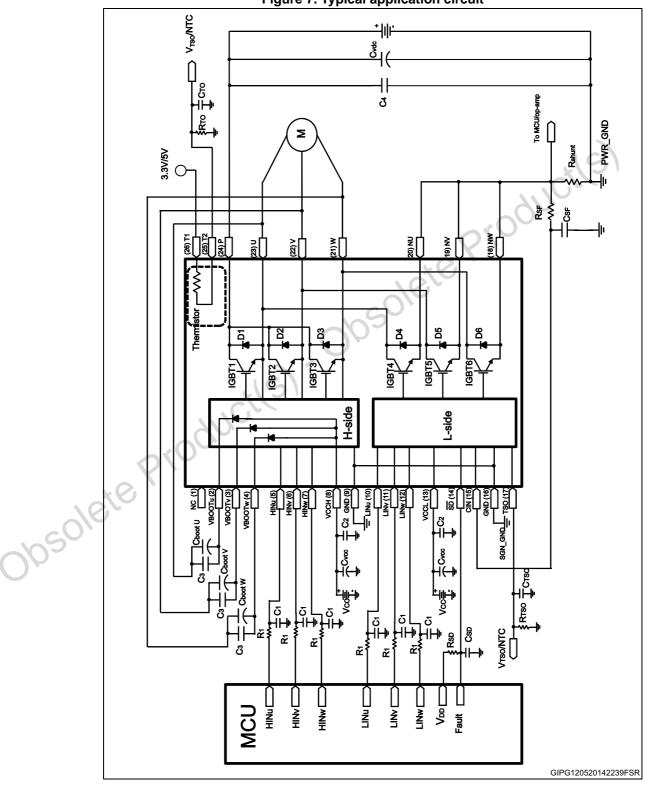


Figure 7. Typical application circuit



6 Recommendations

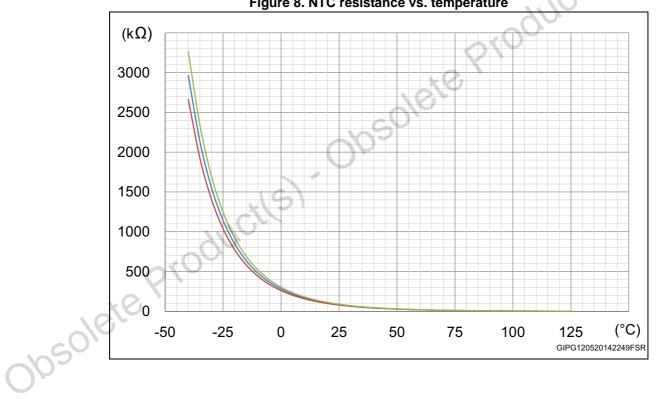
- 1. Input signals HIN, LIN are active-high logic. A 500 k Ω (typ.) pull-down resistor is built-in for each high side input. To prevent input signal oscillation, the wiring of each input should be as short as possible and the use of RC filters (R1, C1) on each input signal is suggested. The filters should be done with a time constant of about 100 ns and must be placed as close as possible to the IPM input pins.
- 2. The bypass capacitor Cvcc (aluminum or tantalum) is recommended to reduce the transient circuit demand on the power supply. In addition, a decoupling capacitor C2 (100 to 220 nF, ceramic with low ESR) is suggested, to reduce high frequency switching noise distributed on the power supply lines. It must be placed as close as possible to each Vcc pin and in parallel to the bypass capacitor.
- 3. The use of RC filter (RSF, CSF) for preventing protection circuit malfunction is recommended. The time constant (RSF x CSF) should be set to 1 µs and the filter must be placed as close as possible to the CIN pin.
- 4. The \overline{SD} is an input/output pin (open drain type if used as output). It should be pulled up to MCU power supply (3.3/5 V) by a resistor higher than 1.8 k Ω in order to keep load lower than 3 mA. The filter on SD has to be sized to get a desired re-starting time after a fault event and placed as close as possible to the SD pin.
- 5. To increase the noise immunity of the NTC thermistor or/and TSO thermal sensor, it is recommended to parallel a decoupling capacitor (COT and CTSO), whose values must be between 10 and 100 nF and placed close to the MCU.
- 6. The decoupling capacitor C3 (100 to 220 nF, ceramic with low ESR), in parallel to each Cboot, is recommended in order to filter high frequency disturbances.
- 7. The decoupling capacitor C4 (100 to 220 nF, ceramic with low ESR) in parallel to the electrolytic capacitor Cvdc is recommended, in order to prevent surge destruction. Both capacitors C4 and Cvdc should be placed as close as possible to the IPM (C4 has priority over Cvdc).
- 8. By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an opto-coupler is possible.
- 9. Low inductance shunt resistors should be used for phase leg current sensing
- 10. In order to avoid malfunctions, the wiring between N pins, the shunt resistor and PWR_GND should be as short as possible.
- 11. It is recommended to connect SGN_GND to PWR_GND at only one point (near the terminal of shunt resistor), in order to avoid any malfunction due to power ground fluctuation.
- 12. Bootstrap negative electrodes should be connected to U,V,W terminals directly and separated from the main output wires.



NTC thermistor 7

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
R ₂₅	Resistance	T = 25°C		85	-	kΩ
R ₁₂₅	Resistance	T = 100°C		2.6	-	kΩ
В	B-constant	T = 25°C to 100°C		4092	-	К
т	Operating temperature range		-40		125	°C









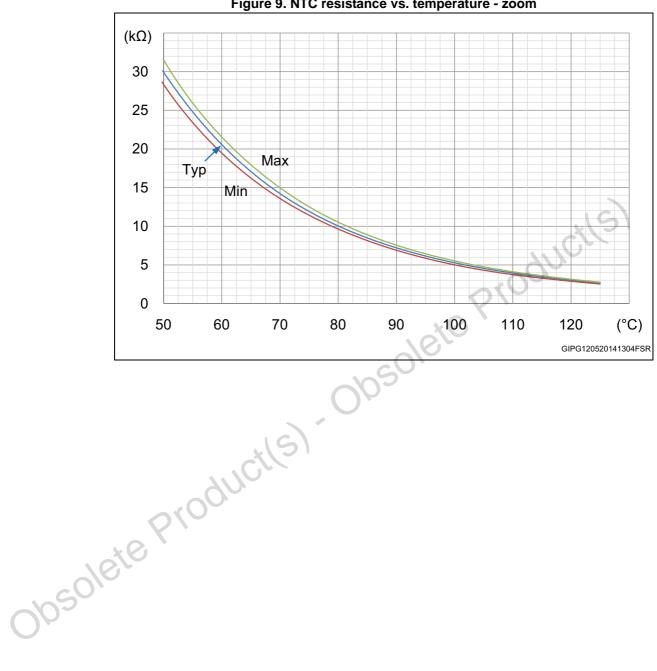


Figure 9. NTC resistance vs. temperature - zoom



8 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



obsolete Product(s). Obsolete Product(s)

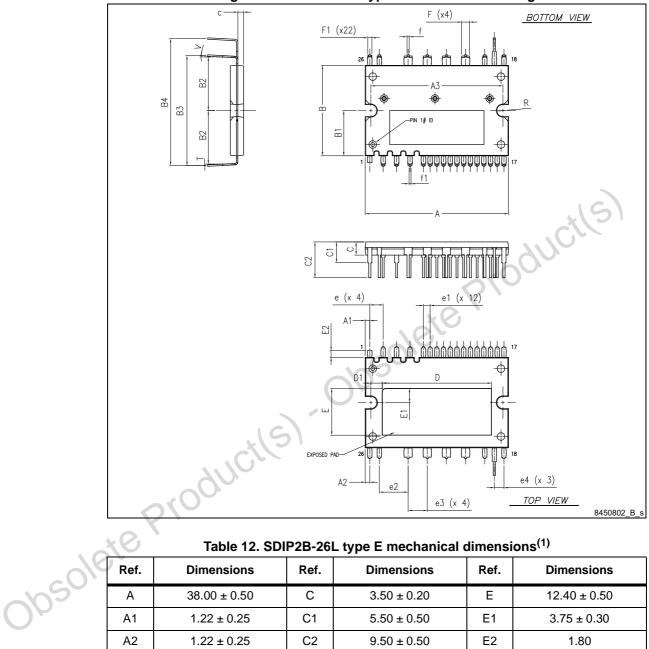


Figure 10. SDIP2B-26L type E mechanical drawing

Table 12. SDIP2B-26L type E mechanical dimensions⁽¹⁾

Ref.	Dimensions	Ref.	Dimensions	Ref.	Dimensions
А	38.00 ± 0.50	С	3.50 ± 0.20	E	12.40 ± 0.50
A1	1.22 ± 0.25	C1	5.50 ± 0.50	E1	3.75 ± 0.30
A2	1.22 ± 0.25	C2	9.50 ± 0.50	E2	1.80
A3	35.00 ± 0.30	е	3.556 ± 0.200	f	0.60 ± 0.15
с	1.50 ± 0.05	e1	1.778 ± 0.200	f1	0.50 ± 0.15
В	24.00 ± 0.50	e2	7.62 ± 0.20	F	2.10 ± 0.15
B1	12.00	e3	5.08 ± 0.20	F1	1.10 ± 0.15
B2	14.40 ± 0.50	e4	2.54 ± 0.20	R	1.60 ± 0.20
B3	29.20 ± 0.50	D	28.95 ± 0.50	Т	0.400 ± 0.025
B4	33.70 ± 0.50	D1	3.025 ± 0.300	V	0° / 5°

1. All dimensions are expressed in millimeters.

DocID026593 Rev 2



9 Revision history

Date	Revision	Changes
23-Jun-2014	1	Initial release.
27-Aug-2014 2		Updated Table 1: Device summary.

57

obsolete Product(s)-Obsolete Product(s)

IMPORTANT NOTICE – PLEASE READ CAREFULLY

obsolete Product(s)

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2014 STMicroelectronics – All rights reserved

DocID026593 Rev 2

